


<b>Search Notes</b>  	<b>Application/Control No.</b>  10583167	<b>Applicant(s)/Patent Under Reexamination</b>  KIM ET AL.
	<b>Examiner</b>  Joey Bednash	<b>Art Unit</b>  2461

SEARCHED			
Class	Subclass	Date	Examiner
370	352	3/25/2010	Joey Bednash
375	219	3/25/2010	Joey Bednash
709	225	3/25/2010	Joey Bednash

SEARCH NOTES		
Search Notes	Date	Examiner
East search history attached	3/25/2010	Joey Bednash
Inventor search in eDAN	3/25/2010	Joey Bednash

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/Joey Bednash/ Examiner.Art Unit 2461	
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